

Features

- 1) Low on-resistance
- 2) Fast switching speed
- 3) Fast reverse recovery
- 4) Easy to parallel
- 5) Simple to drive
- 6) Pb-free lead plating ; RoHS compliant

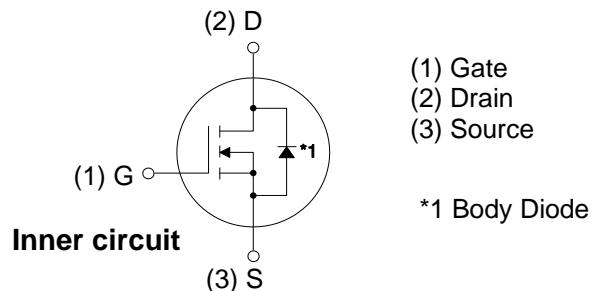
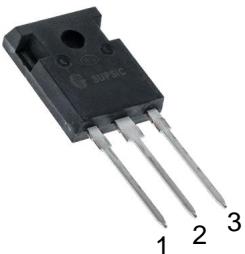
Parameter	Rating	Units
V_{DS}	1700	V
$I_D @ 25^\circ C$	78	A
$R_{DS(on)}$	45	$m\Omega$



Applications

- Solar inverters
- DC/DC converters
- Switch mode power supplies
- Induction heating

TO-247-3
Package



Maximum Ratings ($T_c = 25^\circ C$ unless otherwise specified)

Symbol	Parameter	Value	Unit	Test Conditions	Note
V_{DSmax}	Drain - Source Voltage	1700	V	$V_{GS} = 0 V, I_D = 100 \mu A$	
V_{GSmax}	Gate - Source Voltage	-10/+25	V	Absolute maximum values, AC ($f > 1 Hz$)	
V_{GSop}	Gate - Source Voltage	-5/+20	V	Recommended operational values	
I_D	Continuous Drain Current	78	A	$V_{GS} = 20 V, T_c = 25^\circ C$	
		48		$V_{GS} = 20 V, T_c = 100^\circ C$	
$I_{D(pulse)}$	Pulsed Drain Current	160	A	Pulse width t_p limited by T_{jmax}	
P_D	Power Dissipation	528	W	$T_c = 25^\circ C, T_j = 150^\circ C$	
T_j, T_{stg}	Operating Junction and Storage Temperature	-40 to +150	°C		
T_L	Solder Temperature	260	°C	1.6mm (0.063") from case for 10s	
M_d	Mounting Torque	1 8.8	Nm lbf-in	M3 or 6-32 screw	



APSEMI

AC2M0045170K
Silicon Carbide Power MOSFET
N-Channel Enhancement Mode

Electrical Characteristics ($T_c = 25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions	Note
$V_{(\text{BR})\text{DSS}}$	Drain-Source Breakdown Voltage	1700			V	$V_{GS} = 0 \text{ V}, I_D = 100 \mu\text{A}$	
$V_{GS(\text{th})}$	Gate Threshold Voltage	2.0	2.6	4	V	$V_{DS} = V_{GS}, I_D = 18 \text{ mA}$	
			1.8		V	$V_{DS} = V_{GS}, I_D = 18 \text{ mA}, T_J = 150^\circ\text{C}$	
I_{DSS}	Zero Gate Voltage Drain Current		2	100	μA	$V_{DS} = 1700 \text{ V}, V_{GS} = 0 \text{ V}$	
I_{GSS}	Gate-Source Leakage Current			600	nA	$V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$	
$R_{DS(\text{on})}$	Drain-Source On-State Resistance		45	70	$\text{m}\Omega$	$V_{GS} = 20 \text{ V}, I_D = 50 \text{ A}$	
			90			$V_{GS} = 20 \text{ V}, I_D = 50 \text{ A}, T_J = 150^\circ\text{C}$	
g_{fs}	Transconductance		22		S	$V_{DS} = 20 \text{ V}, I_{DS} = 50 \text{ A}$	
			24.4			$V_{DS} = 20 \text{ V}, I_{DS} = 50 \text{ A}, T_J = 150^\circ\text{C}$	
C_{iss}	Input Capacitance		3617		pF	$V_{GS} = 0 \text{ V}$	
C_{oss}	Output Capacitance		174			$V_{DS} = 1200 \text{ V}$	
C_{rss}	Reverse Transfer Capacitance		6.7			$f = 1 \text{ MHz}$	
E_{oss}	C_{oss} Stored Energy		105			$V_{AC} = 25 \text{ mV}$	
E_{ON}	Turn-On Switching Energy (SiC Diode FWD)		2.1		mJ	$V_{DS} = 1200 \text{ V}, V_{GS} = -5/20 \text{ V}$	
E_{OFF}	Turn Off Switching Energy (SiC Diode FWD)		0.86			$I_D = 50 \text{ A}, R_{G(\text{ext})} = 2.5 \Omega, L = 105 \mu\text{H}, T_J = 150^\circ\text{C}$, using SiC Diode as FWD	
E_{ON}	Turn-On Switching Energy (Body Diode FWD)		4.7			$V_{DS} = 1200 \text{ V}, V_{GS} = -5/20 \text{ V}$	
E_{OFF}	Turn Off Switching Energy (Body Diode FWD)		0.93			$I_D = 50 \text{ A}, R_{G(\text{ext})} = 2.5 \Omega, L = 105 \mu\text{H}, T_J = 150^\circ\text{C}$, using MOSFET as FWD	
$t_{d(on)}$	Turn-On Delay Time		65		ns	$V_{DD} = 1200 \text{ V}, V_{GS} = -5/20 \text{ V}$	
t_r	Rise Time		20			$I_D = 50 \text{ A}, R_{G(\text{ext})} = 2.5 \Omega$, Timing relative to V_{DS}	
$t_{d(off)}$	Turn-Off Delay Time		48			Inductive load	
t_f	Fall Time		18				
$R_{G(\text{int})}$	Internal Gate Resistance		1.3		Ω	$f = 1 \text{ MHz}, V_{AC} = 25 \text{ mV}$	
Q_{gs}	Gate to Source Charge		44		nC	$V_{DS} = 1200 \text{ V}, V_{GS} = -5/20 \text{ V}$	
Q_{gd}	Gate to Drain Charge		57			$I_D = 50 \text{ A}$	
Q_g	Total Gate Charge		186			Per IEC60747-8-4 pg 21	

Reverse Diode Characteristics

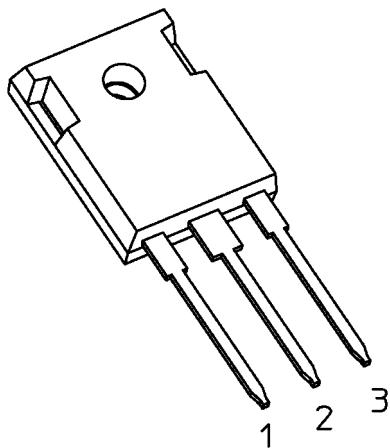
Symbol	Parameter	Typ.	Max.	Unit	Test Conditions	Note
V_{SD}	Diode Forward Voltage	4.1		V	$V_{GS} = -5 \text{ V}, I_{SD} = 25 \text{ A}$	
		3.6		V	$V_{GS} = -5 \text{ V}, I_{SD} = 25 \text{ A}, T_J = 150^\circ\text{C}$	
I_s	Continuous Diode Forward Current		72	A	$T_c = 25^\circ\text{C}, V_{GS} = -5 \text{ V}$	
t_{rr}	Reverse Recovery Time	70		ns	$V_{GS} = -5 \text{ V}, I_{SD} = 50 \text{ A}, V_R = 1200 \text{ V}$ $dI/dt = 1400 \text{ A}/\mu\text{s}$	
Q_{rr}	Reverse Recovery Charge	531		nC		
I_{rrm}	Peak Reverse Recovery Current	14		A		

Note (1): When using SiC Body Diode the maximum recommended $V_{GS} = -5 \text{ V}$

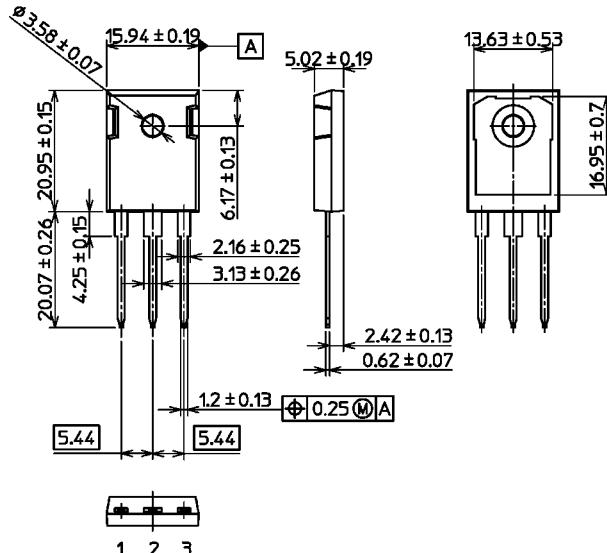
Thermal Characteristics

Symbol	Parameter	Typ.	Max.	Unit	Test Conditions	Note
$R_{\theta JC}$	Thermal Resistance from Junction to Case	0.22	0.24	$^\circ\text{C}/\text{W}$		
$R_{\theta JA}$	Thermal Resistance from Junction to Ambient		40			

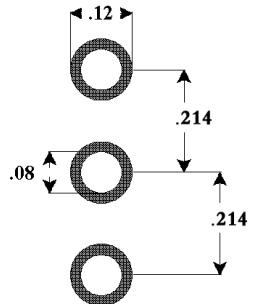
Package Dimensions



TO-247-3



Recommended Solder Pad Layout



TO-247-3